

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/620,594	SAKAI ET AL.	
Examiner	Art Unit	
SAMUEL S. WEIS	3693	

	SEAR	CHED	
Class	Subclass	Date	Examiner

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
	<u> </u>				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East (Attached)	6/6/2008	SW